AST 2008
List of Accepted Papers

#01: Junhua Ding, Peter J. Clarke, Gonzalo Argote-Garcia and Xudong He. *Evaluating Test Adequacy Coverage of High Level Petri Nets Using Spin*, (Full Paper)

#02: J. Jenny Li, David Weiss and Howell Yee. *An Automatically-Generated Run-Time Instrumenter to Reduce Coverage Testing Overhead*, (Full Paper)

#03: Stephen Masticola and Michael Gall. *Vision: Testing of Mechatronics Software using Agile Simulation*, (Full Paper)

#06: Leila Naslavsky, Hadar Ziv and Debra Richardson. *Using Model Transformation to Support Model-Based Test Coverage Measurement*, (Full Paper)

#08: Arilo Dias Neto and Guilherme Travassos. *Supporting the Selection of Model-based Testing Approaches for Software Projects*, (Short Paper)

#10: Ning Zhong, Zhihai Zhuo and Jing-ming Kuang. *A Generic Formal framework for Protocol Interoperability Test and Test Cases Minimization*, (Full Paper)

#11: Fabrice Bouquet, christophe grandpierre, Bruno Legeard and fabien peureux. *A Test Generation Solution to Automate Software Testing*, (Short Paper)

#12: José Carlos Ribeiro, Mário Zenha-Rela and Francisco Vega. *A Strategy for Evaluating Feasible and Unfeasible Test Cases for the Evolutionary Testing of Object-Oriented Software*, (Full Paper)

#13: Jacques Julliand, Pierre-Alain Masson and Regis Tissot. *Generating Security Tests in Addition to Functional Tests*, (Short Paper)

#15: Harald Brandl, Gordon Fraser and Franz Wotawa. *QR-Model Based Testing*, (Short Paper)

#17: Christian Pfaller. *Requirements-Based Test Case Specification by Using Information from Model Construction*, (Full Paper)

#20: Svetoslav Ganov, Chip Killmar and Sarfraz Khurshid. *Test Generation for Graphical User Interfaces Based on Symbolic Execution*, (Full Paper)

#24: Dave Arnold and Jean-Pierre Corriveau. *An Open Framework for the Specification and Execution of Conformance Tests using Scenarios*, (Short Paper)

#25: Heiko Stallbaum, Andreas Metzger and Klaus Pohl. *An Automated Technique for Risk-based Test Case Generation and Prioritization*, (Short Paper)

#28: Eric Wong, Andy Restrepo, Yu Qi and Byoungju Choi. *An EFSM-based Test Generation for Validation of SDL Specifications*, (Full Paper)